

Search Notes

Application/Control No.

10/534,870

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

ISHII ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	10	3/5/2007	PN
	207A		
	251		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
330	10	3/5/2007	PN
	207A		
	251		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		